

An IATF 16949, ISO9001 and ISO 14001/ISO 45001 Certified Company





40A Schottky Barrier Rectifier

Reverse Voltage - 45 Volts Forward Current - 40 Ampere

CD40T45PA





Module 012-A Plastic Package RoHS compliant

Module 012-A

FEATURE:

- 1. The plastic package carries Underwriters Laboratory Flammability Classification 94V-0
- 2. Construction utilizes void-free molded plastic technique
- 3. Low reverse leakage
- 4. High forward surge current capability
- 5. High temperature soldering guaranteed: 260 C, 10 seconds
- 6. High temperature manual soldering guaranteed 380 C, 5 seconds
- 7. With Tin Blocks.

ABSOLUTE MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 C ambient temperature unless otherwise specified.

Single phase half-wave 60Hz, resistive or inductive load, for capacitive load current derate by 20%

PARAMETER		SYMBOL	VALUE	UNIT
Maximum repetitive peak reverse voltage		V_{RRM}	45	V
Maximum RMS voltage		V _{RMS}	32	V
Maximum average forward rectified current Fig. 1		I _(AV)	40	Α
Peak forward surge current 8.3ms single half sine-wave superimposed on rated load (JEDEC Method)		I FSM	300	А
Maximum instantaneous forward voltage at 30A		V_{F}	0.55	V
Maximum DC reverse current at	T _A =25° C	I R	120	μΑ
rated DC blocking voltage	T _A =100° C	I R	20	mA
Rating for Fusing 1ms≤t <8.3ms		l ² t	374	A ² s
Typical thermal resistance ¹		Rejc	1	°C/W
Operating junction temperature range ²		T_J	-55 to +200	°C
Storage temperature range		T _{STG}	-55 to +150	°C

Note: 1.Thermal resistance from junction to case

2.In DC forward mode-forward operations without reverse bias,t ≤1 h









TYPICAL CHARACTERISTICS CURVES

FIG. 1- Forward Current Derating Curve

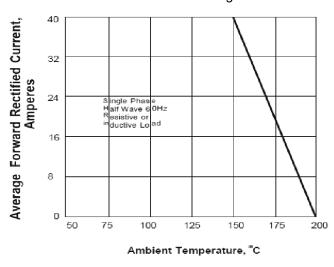


FIG. 3-Typical Instantaneous Forward Characteristics

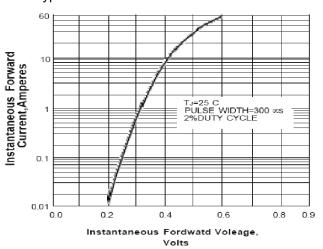


FIG. 2-Maximum Non-repetitive Peak Forward Surge Current

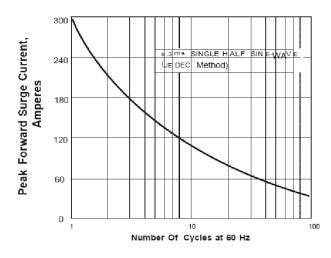
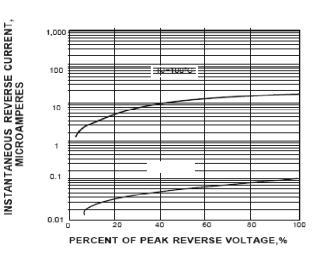


FIG. 4-TYPICAL REVERSE CHARACTERISTICS





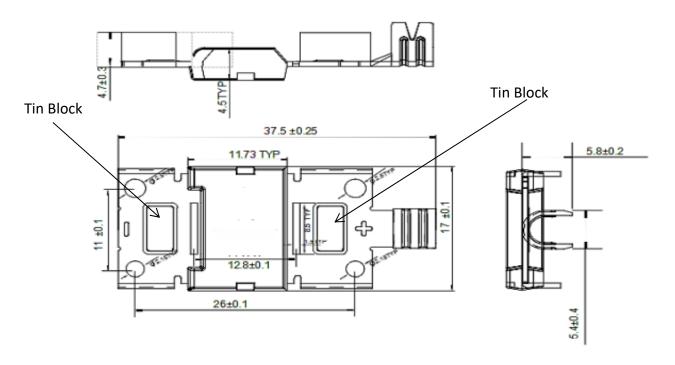
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PACKAGE DETAILS

Module 012-A



Dimensions in millimeters

MECHANICAL DATA

Case: Module 012-A molded plastic body

Terminals: Leads solderable per MIL-STD-750, Method 2026

Polarity: As marked **Mounting Position**: Any





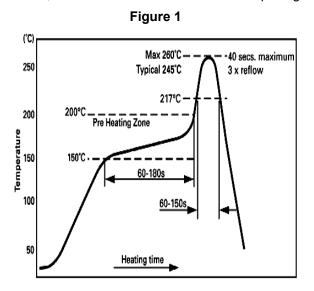


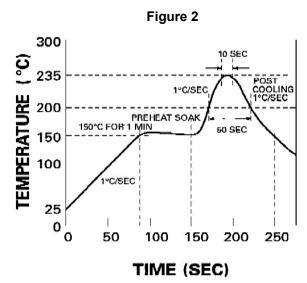
Recommended Reflow Solder Profiles

The recommended reflow solder profiles for Pb and Pb-free devices are shown below.

Figure 1 shows the recommended solder profile for devices that have Pb-free terminal plating, and where a Pb-free solder is used.

Figure 2 shows the recommended solder profile for devices with Pb-free terminal plating used with leaded solder, or for devices with leaded terminal plating used with a leaded solder.





Reflow profiles in tabular form

Profile Feature	Sn-Pb System	Pb-Free System	
Average Ramp-Up Rate	~3°C/second	~3°C/second	
Preheat – Temperature Range – Time	150-170°C 60-180 seconds	150-200°C 60-180 seconds	
Time maintained above: – Temperature – Time	200°C 30-50 seconds	217°C 60-150 seconds	
Peak Temperature	235°C	260°C max.	
Time within +0 -5°C of actual Peak	10 seconds	40 seconds	
Ramp-Down Rate	3°C/second max.	6°C/second max.	



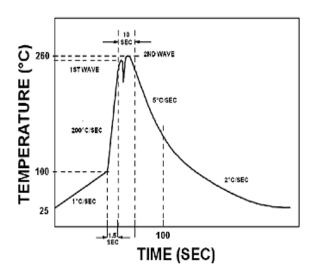




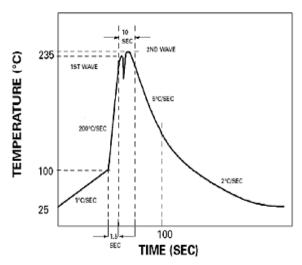


Recommended Wave Solder Profiles

The Recommended solder Profile For Devices with Pb-free terminal plating where a Pb-free solder is used



The Recommended solder Profile For Devices with Pb-free terminal plating used with leaded solder, or for devices with leaded terminal plating used with leaded solder



Wave Profiles in Tabular Form

Profile Feature	Sn-Pb System	Pb-Free System
Average Ramp-Up Rate	~200°C/second	~200°C/second
Heating rate during preheat	Typical 1-2, Max 4°C/sec	Typical 1-2, Max 4°C/Sec
Final preheat Temperature	Within 125°C of Solder Temp	Within 125°C of Solder Temp
Peak Temperature	235°C	260°C max.
Time within +0 -5°C of actual Peak	10 seconds	10 seconds
Ramp-Down Rate	5°C/second max.	5°C/second max







Recommended Product Storage Environment for Discrete Semiconductor Devices

This storage environment assumes that the Diodes and transistors are packed properly inside the original packing supplied by CDIL.

- · Temperature 5 °C to 30 °C
- · Humidity between 40 to 70 %RH
- · Air should be clean.
- · Avoid harmful gas or dust.
- · Avoid outdoor exposure or storage in areas subject to rain or water spraying .
- · Avoid storage in areas subject to corrosive gas or dust. Product shall not be stored in areas exposed to direct sunlight.
- · Avoid rapid change of temperature.
- · Avoid condensation.
- · Mechanical stress such as vibration and impact shall be avoided.
- · The product shall not be placed directly on the floor.
- The product shall be stored on a plane area. They should not be turned upside down. They should not be placed against the wall.

Shelf Life of CDIL Products

The shelf life of products is the period from product manufacture to shipment to customers. The product can be unconditionally shipped within this period. The period is defined as 2 years.

If products are stored longer than the shelf life of 2 years the products shall be subjected to quality check as per CDIL quality procedure.

The products are further warranted for another one year after the date of shipment subject to the above conditions in CDIL original packing.

Floor Life of CDIL Products and MSL Level

When the products are opened from the original packing, the floor life will start.

For this, the following JEDEC table may be referred:

JEDEC MSL Level				
Level	Time	Condition		
1	Unlimited	≤30 °C / 85% RH		
2	1 Year	≤30 °C / 60% RH		
2a	4 Weeks	≤30 °C / 60% RH		
3	168 Hours	≤30 °C / 60% RH		
4	72 Hours	≤30 °C / 60% RH		
5	48 Hours	≤30 °C / 60% RH		
5a	24 Hours	≤30 °C / 60% RH		
6	Time on Label(TOL)	≤30 °C / 60% RH		







Customer Notes

Component Disposal Instructions

- 1. CDIL Semiconductor Devices are RoHS compliant, customers are requested to please dispose as per prevailing Environmental Legislation of their Country.
- 2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).

Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished in the Data Sheet and on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving/support appliances or systems. CDIL customers selling these products (either as individual Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

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